

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10775668	MACK ET AL.
	<b>Examiner</b> Tayong, Helene	<b>Art Unit</b> 2609

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	130, 140,141,146,142,147,150,505	1/30/07	HT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
US_PGPUB, USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM-TDB	1/29/07	Helene Tayong
GOOGLE	1/29/07	Helene Tayong
EAST/WEST	1/29/07	Helene Tayong
IEEE EXPLORER	1/29/07	Helene Tayong
Consult with Search Assistant in 2609	1/29/07	Helene Tayong

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>